

# MBN800H45E2-H

Silicon N-channel IGBT 4500V E2 version

## FEATURES

- \* Low switching loss IGBT module.
- \* Low noise due to ultra soft fast recovery diode.
- \* High reliability, high durability module.
- \* High thermal fatigue durability.  
( $\Delta T_c=70^\circ\text{C}$ ,  $N>30,000$ cycles)
- \* Isolated heat sink (terminal to base).

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ )

Item	Symbol	Unit	MBN800H45E2-H
Collector Emitter Voltage	$V_{CES}$	V	4,500
Gate Emitter Voltage	$V_{GES}$	V	$\pm 20$
Collector Current	DC	$I_C$	800 ( $T_c=80^\circ\text{C}$ )
	1ms	$I_{CP}$	1,600
Forward Current	DC	$I_F$	800
	1ms	$I_{FM}$	1,600
Junction Temperature	$T_j$	$^\circ\text{C}$	$-40 \sim +125$
Maximum Junction Temperature(1)	$T_{vj\max}$	$^\circ\text{C}$	150
Storage Temperature	$T_{stg}$	$^\circ\text{C}$	$-50 \sim +125$ (2)
Isolation Voltage	$V_{ISO}$	$V_{RMS}$	10,200 (AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/10 (3)
	Mounting (M6)	-	6 (4)

Notes:(1) Regarding the condition of  $T_{vj\max}$  for each operation mode, please refer to LD-ES-130737.

(2) Terminal temperature shall not exceed the specified temperature in any operation.

(3) Recommended Value  $1.8\pm 0.2/9\pm 1\text{N}\cdot\text{m}$  (4) Recommended Value  $5.5\pm 0.5\text{N}\cdot\text{m}$ 

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	$I_{CES}$	mA	-	-	17	$V_{CE}=4,500\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=25^\circ\text{C}$
			-	17	67	$V_{CE}=4,500\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Gate Emitter Leakage Current	$I_{GES}$	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	3.5	4.2	4.7	$I_C=800\text{A}$ , $V_{GE}=15\text{V}$ , $T_j=125^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(TH)}$	V	5.4	6.4	7.4	$V_{CE}=10\text{V}$ , $I_C=800\text{mA}$ , $T_j=25^\circ\text{C}$
Input Capacitance	$C_{ies}$	nF	-	110	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Internal Gate Resistance	$R_{ge}$	$\Omega$	-	1.2	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Rise Time	$t_r$	$\mu\text{s}$	1.0	2.1	4.2	$V_{CC}=2,600\text{V}$ , $I_C=800\text{A}$
Turn On Delay Time	$t_{d(on)}$		-	0.6	-	$L_s=165\text{nH}$
Fall Time	$t_f$		1.2	2.4	3.6	$R_g=4.7\Omega$ (5)
Turn Off Delay Time	$t_{d(off)}$		-	2.4	-	$V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Forward Voltage Drop	$V_{FM}$	V	3.0	3.7	4.2	$I_F=800\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	$\mu\text{s}$	0.3	0.7	1.4	$V_{CC}=2,600\text{V}$ , $I_F=800\text{A}$ , $L_s=165\text{nH}$ $T_j=125^\circ\text{C}$
Turn On Loss	$E_{on(10\%)}$	J/p	-	2.1	3.2	$V_{CC}=2,600\text{V}$ , $I_C=I_F=800\text{A}$ , $L_s=165\text{nH}$ $R_g=4.7\Omega$ (5) $V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
	$E_{on(full)}$		-	2.5	-	
Turn Off Loss	$E_{off(10\%)}$	J/p	-	2.1	3.2	
	$E_{off(full)}$		-	2.5	-	
Reverse Recovery Loss	$E_{rr(10\%)}$	J/p	-	1.7	2.5	
	$E_{rr(full)}$		-	1.9	-	
Thermal Impedance	IGBT	$R_{th(j-c)}$	K/W	-	0.013	Junction to case
	FWD	$R_{th(j-c)}$	K/W	-	0.026	
Contact Thermal Impedance		$R_{th(c-f)}$	K/W	-	0.007	Case to fin ( $\lambda_{grease}=1\text{W}/(\text{m}\cdot\text{K})$ , Heat-sink flatness $\leq 50\mu\text{m}$ )

Notes:(5)  $R_g$  value is the test condition's value for evaluation of the switching times, not recommended value.Please, determine the suitable  $R_g$  value after the measurement of switching waveforms

(overshoot voltage, etc.) with appliance mounted.

\* Please contact our representatives at order.

\* For improvement, specifications are subject to change without notice.

\* For actual application, please confirm this spec sheet is the newest revision.

# MBN800H45E2-H

## DEFINITION OF TEST CIRCUIT

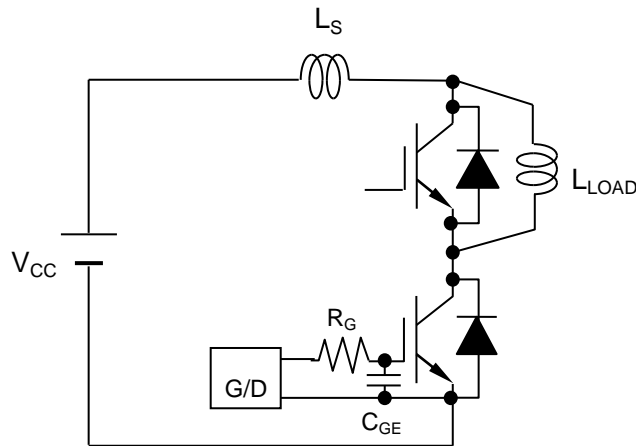


Fig.1 Switching test circuit

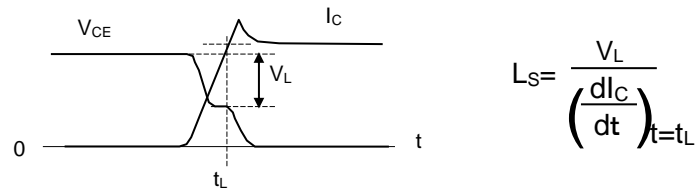


Fig.2 Definition of stray inductance

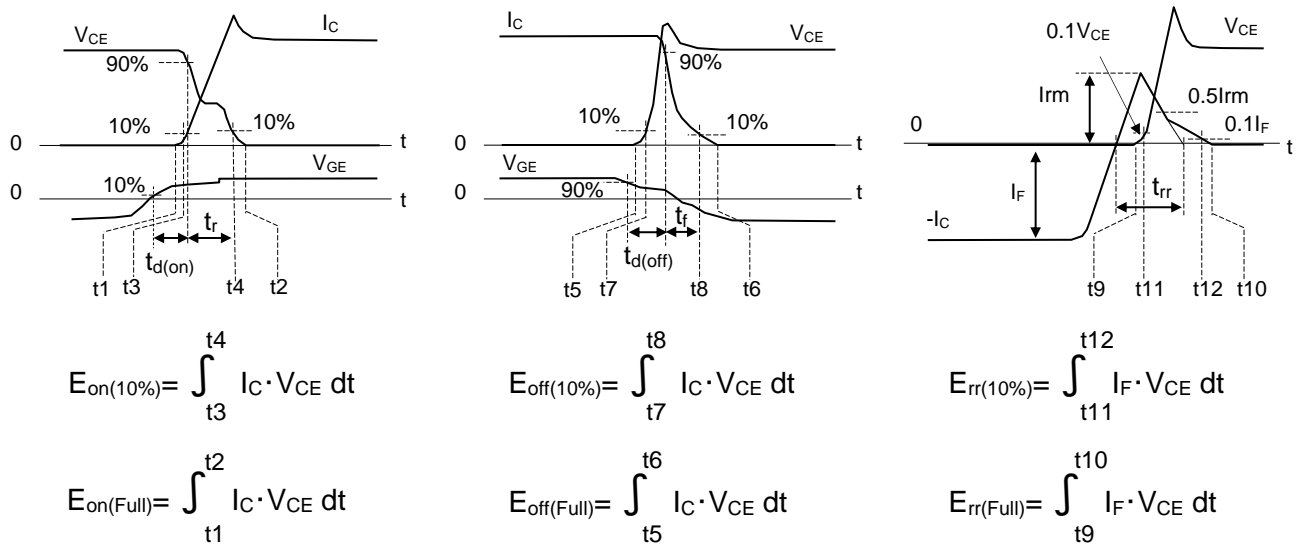
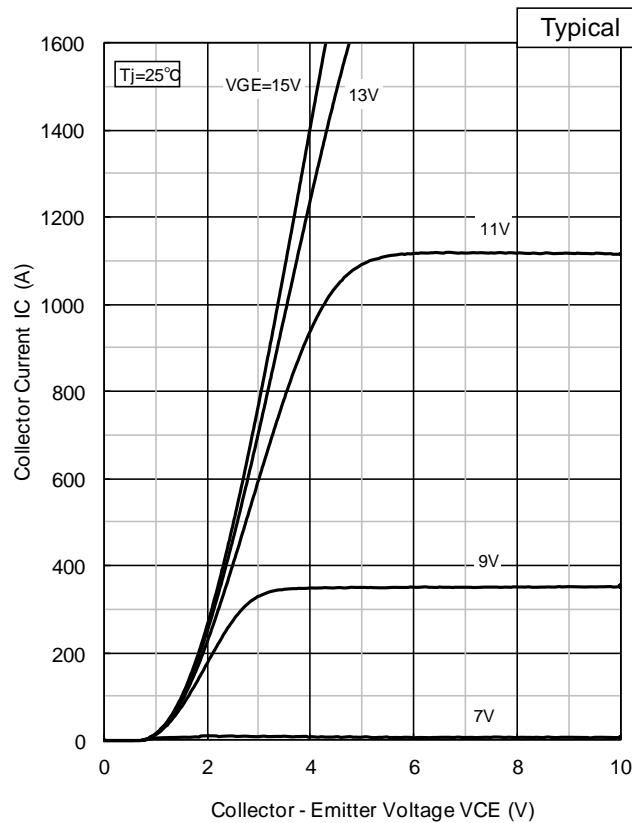


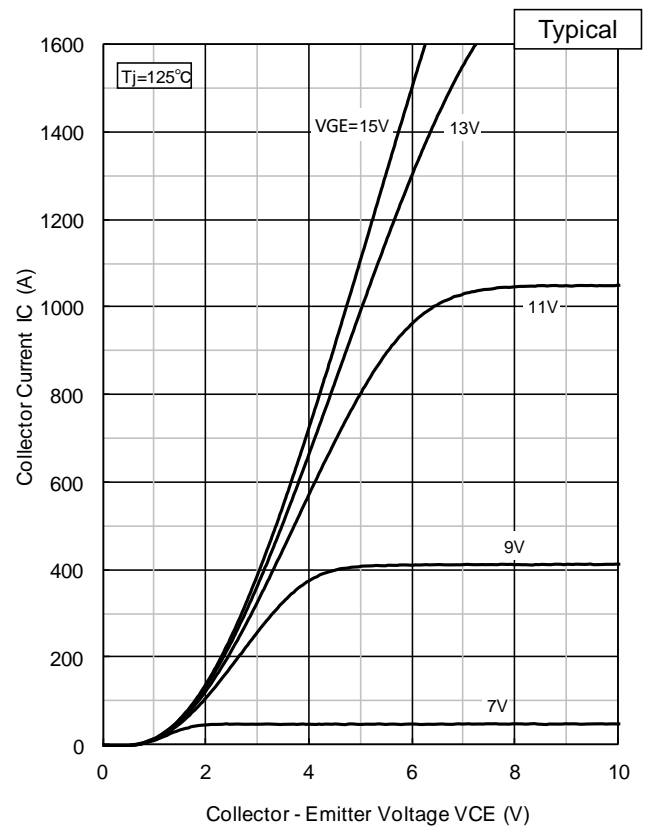
Fig.3 Definition of switching loss

# MBN800H45E2-H

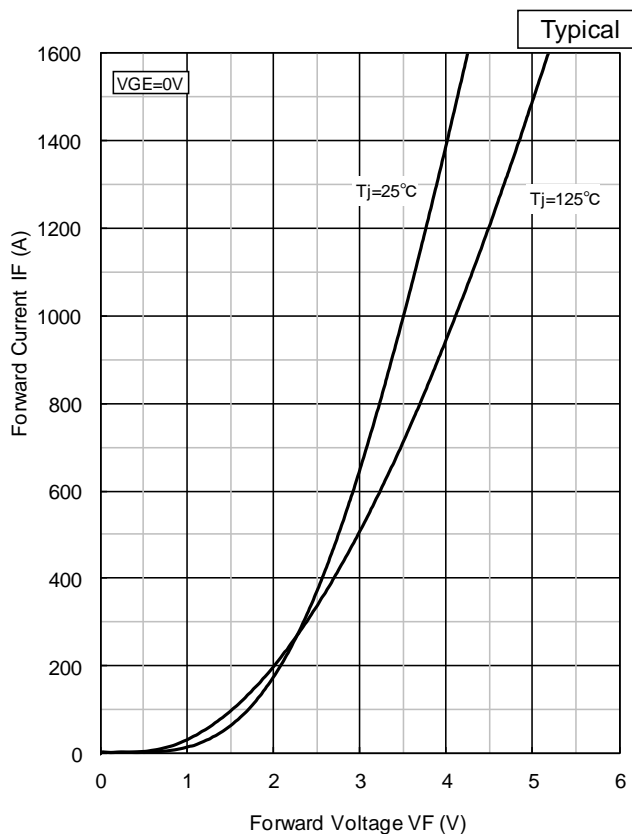
## STATIC CHARACTERISTICS



**IC vs. VCE ( $T_j=25^\circ\text{C}$ )**



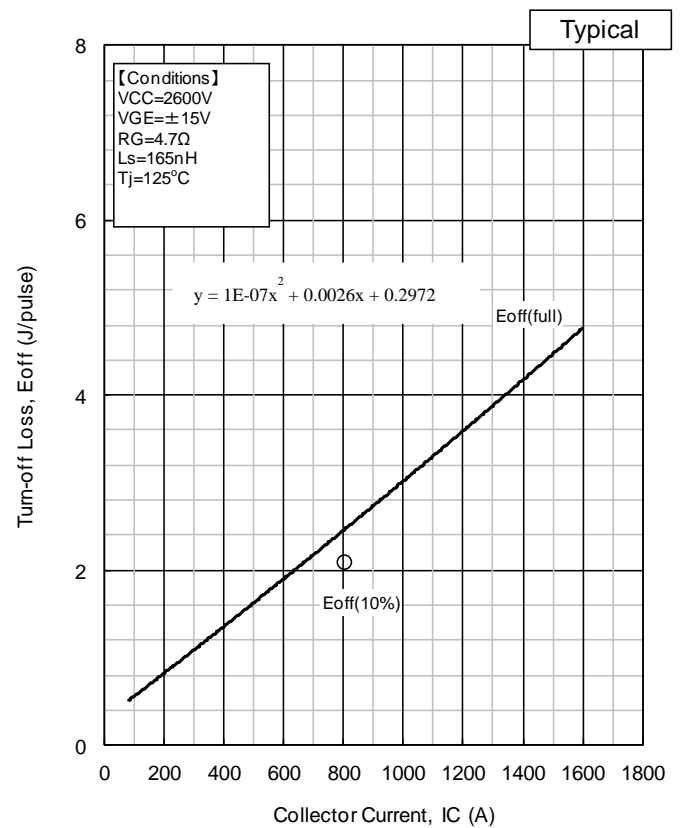
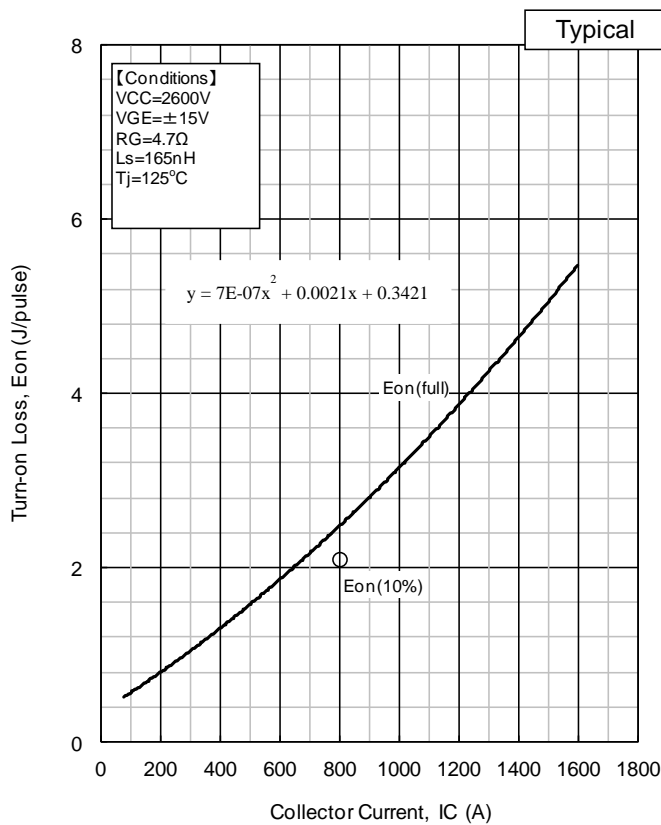
**IC vs. VCE ( $T_j=125^\circ\text{C}$ )**



**IF vs. VF**

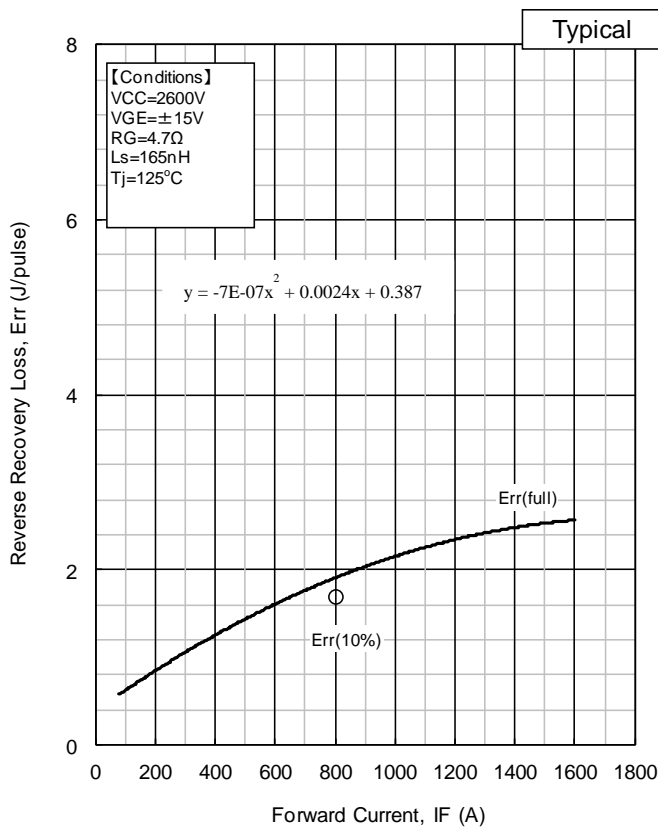
# MBN800H45E2-H

## DYNAMIC CHARACTERISTICS

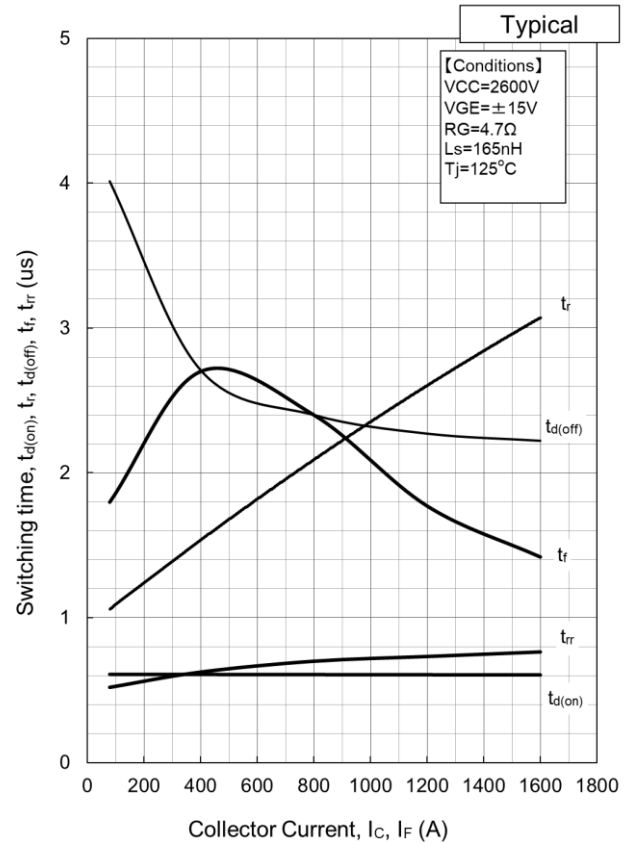


Turn-on loss vs. Collector current

Turn-off loss vs. Collector current

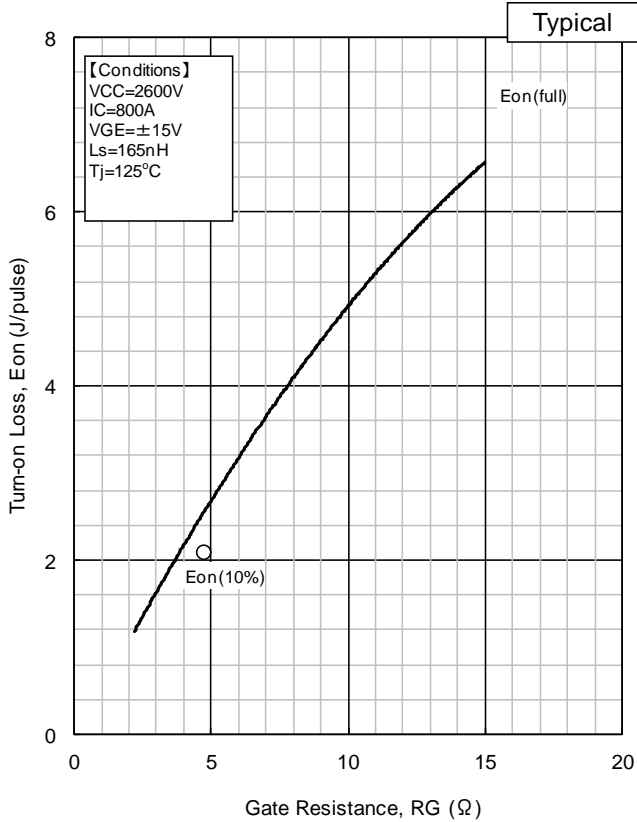


Recovery loss vs. Forward current

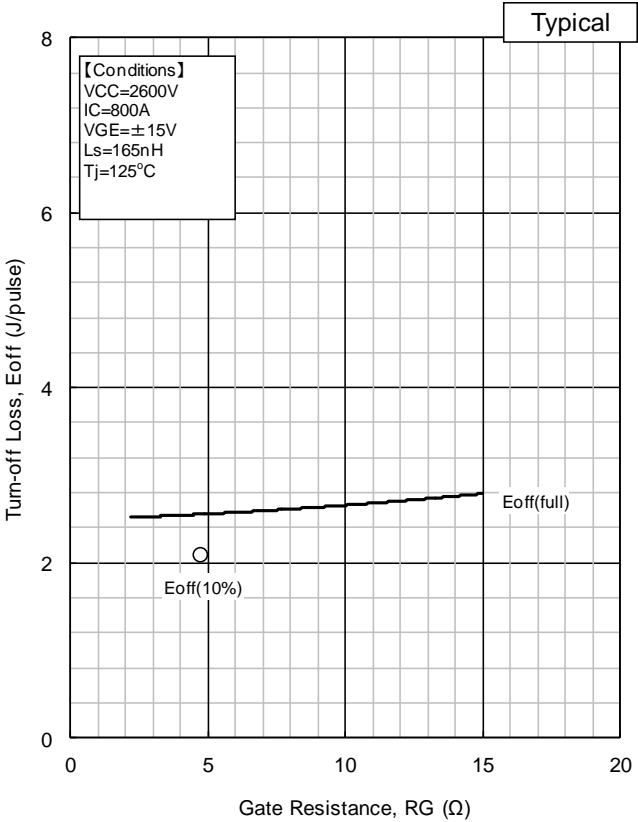


Switching time vs. Collector Current

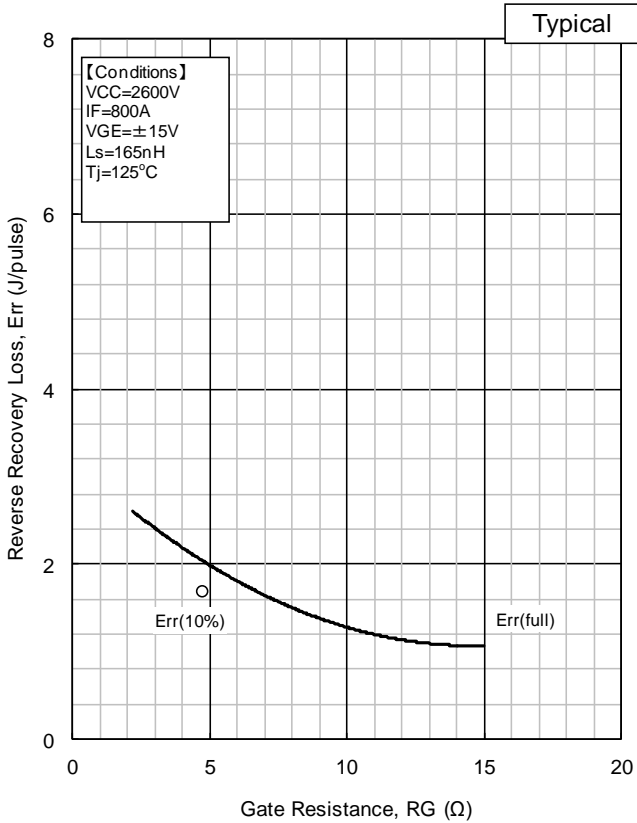
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Turn-on loss vs. Gate Resistance



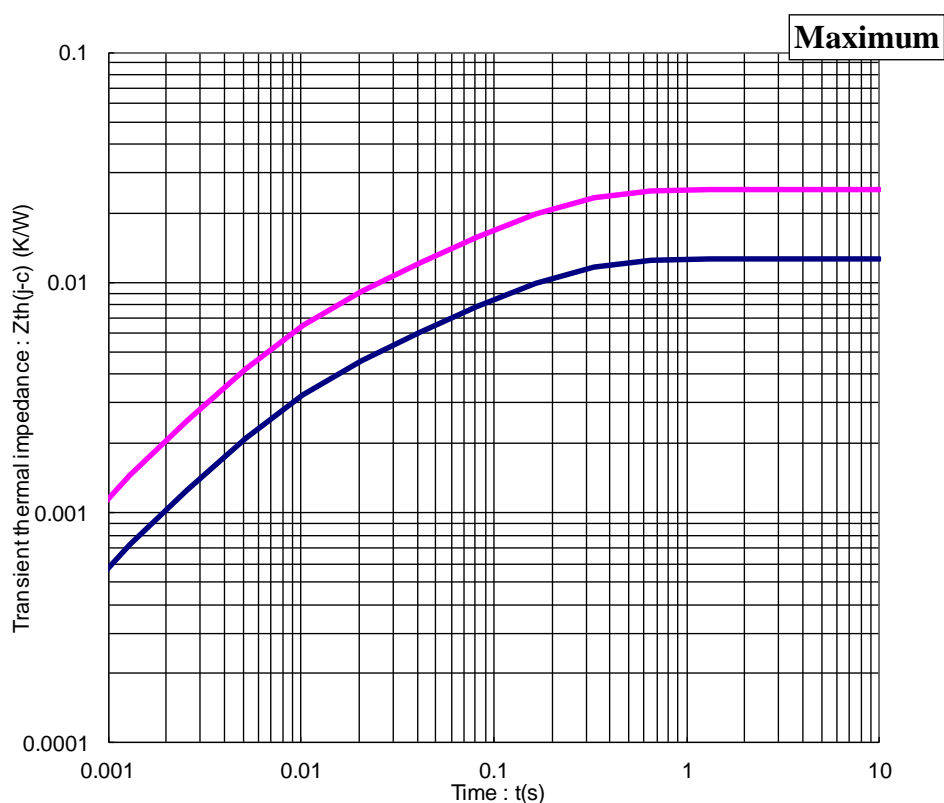
Turn-off loss vs. Gate Resistance



Recovery loss vs. Gate Resistance

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## TRANSIENT THERMAL IMPEDANCE



**Transient Thermal Impedance Curve (Maximum Value)**

Curve approximation model  
 $(\sum r_{th}[n] \cdot (1 - \exp(-t/\tau_{th}[n])))$

n	1	2	3	4	Unit
$\tau_{th}[n]$	1.63E-01	2.71E-02	6.11E-03	8.61E-04	sec
$r_{th}[n,IGBT]$	8.05E-03	2.47E-03	2.39E-03	1.31E-04	K/W
$r_{th}[n,Diode]$	1.61E-02	4.91E-03	4.76E-03	2.61E-04	K/W

### ● Material declaration

Please note that following materials are contained in the product  
 In order to keep characteristics and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

## Module Outline Drawing

Technical drawing of a mechanical assembly, showing front, side, and detail views with dimensions and tolerances.

**Front View Dimensions:**

- Overall width:  $130 \pm 1$
- Overall height:  $140 \pm 1$
- Top section height:  $4 - M8$
- Section height:  $(18)$
- Section height:  $(44)$
- Section height:  $124 \pm 1$
- Section height:  $140 \pm 1$
- Bottom section height:  $6 - \phi 7 \pm 0.1$
- Section height:  $28.5 \pm 0.8$
- Section height:  $42.5 \pm 0.8$
- Section height:  $30.7 \pm 0.8$
- Section height:  $3 - M4$

**Side View Dimensions:**

- Overall width:  $114 \pm 1$
- Section height:  $41.0 \pm 0.8$
- Section height:  $18.0 \pm 0.8$
- Section height:  $38.5^{+1}_{-0.2}$

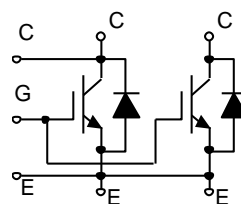
**Detail View Dimensions:**

- Section height:  $61.2 \pm 0.5$
- Section height:  $16.5 \pm 0.8$
- Section height:  $48.0^{+1.5}_{-0}$
- Section height:  $(5)$

**Annotations:**

- screwing depth max. 8
- screwing depth max. 16

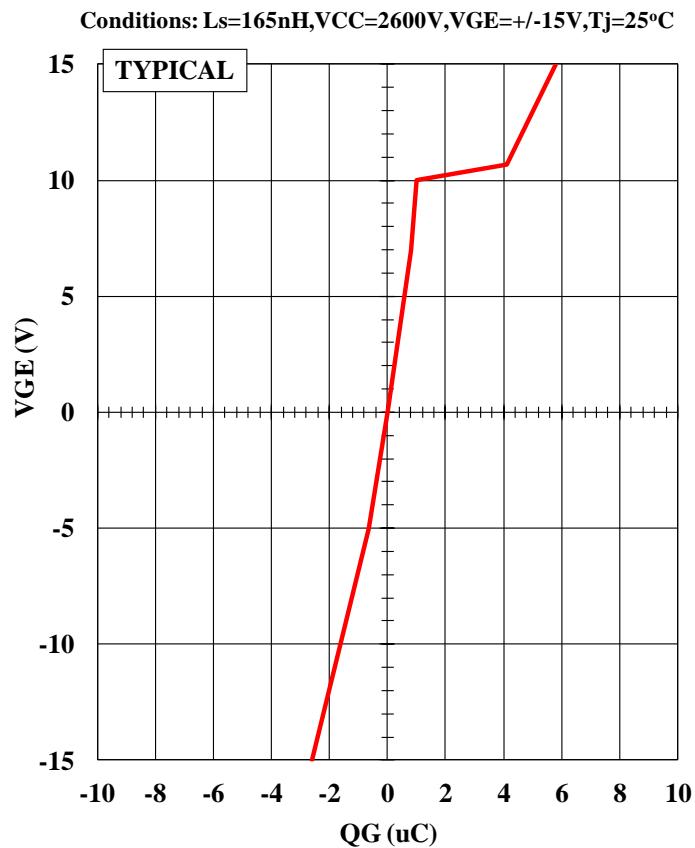
### Circuit diagram



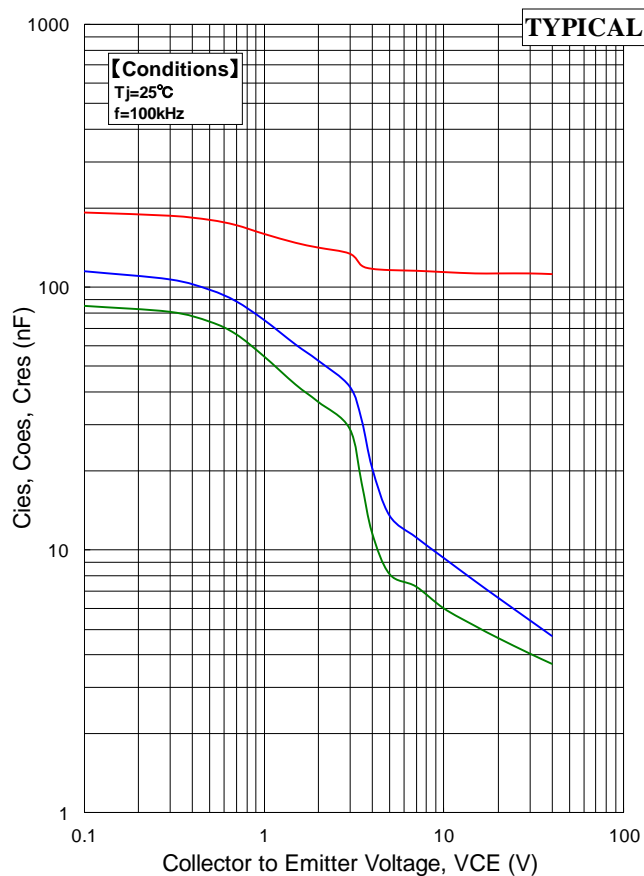
## TERMINALS

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## QG-VGE Curve



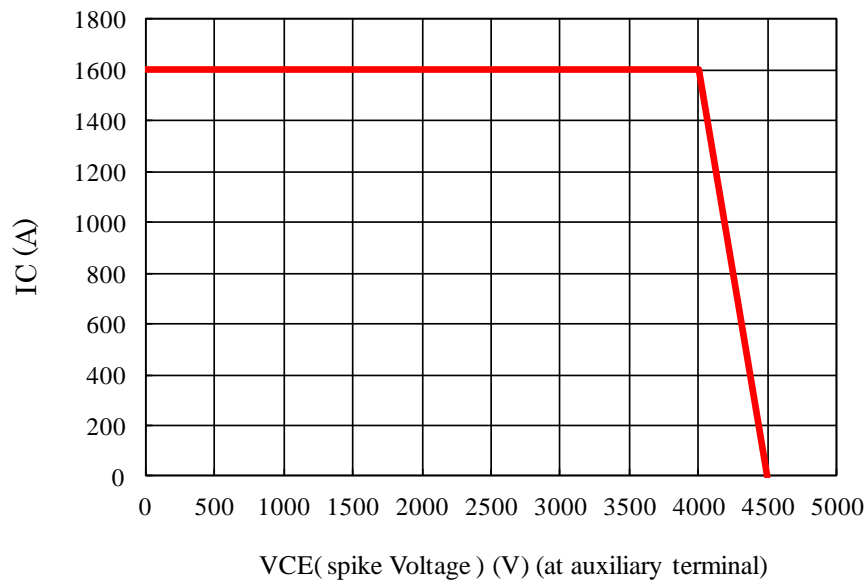
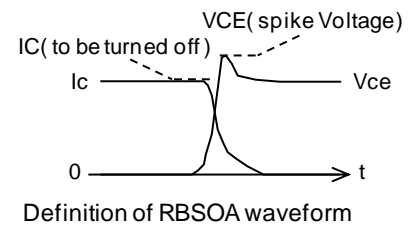
## Cies, Coes, Cres Curve



# MBN800H45E2-H

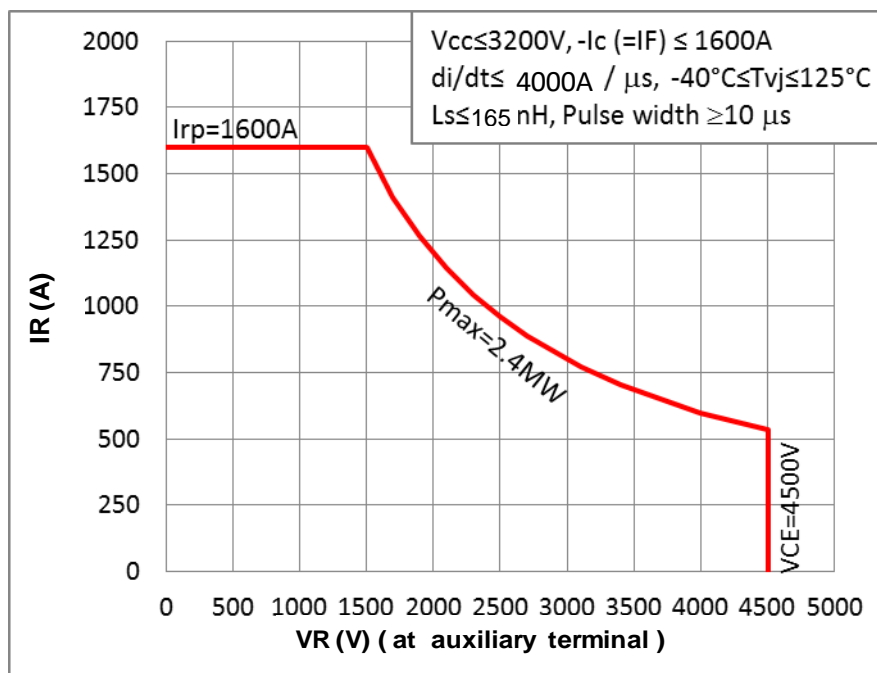
## RBSOA

Conditions:  $V_{cc} \leq 3000V$ ,  $I_c \leq 1600A$ ,  
 $R_g \geq 4.7\Omega$ ,  
 $V_{GE} = \pm 15V$ ,  $-40^\circ C \leq T_j \leq 125^\circ C$ ,  
 $L_s \leq 165nH$ , on pulse width  $\geq 10\mu s$   
 (  $V_{ce}$  spike voltage and  $L_s$  are defined at auxiliary terminal)



## Reverse bias safe operation area ( RBSOA )

## Reverse Recovery SOA



# MBN800H45E2-H

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5. A semi-processed article is done now using solder which contains lead inside the semiconductor devices. There is possibility of the regulation substance depend on the applied models, so please check before using.
6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
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